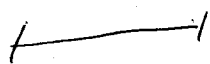


$$\begin{aligned}
 E(T) &= \int_0^{\infty} t f(t) dt = \int_0^{\infty} \left[\int_0^t du \right] f(t) dt \\
 &= \int_0^{\infty} \left[\int_0^{\infty} I(t > u) du \right] f(t) dt \\
 &\quad \downarrow I(t) = \begin{cases} 0 & \text{if } t < u \\ 1 & \text{otherwise} \end{cases} \\
 &= \int_0^{\infty} \left[\int_0^{\infty} I(t > u) f(t) dt \right] du \\
 &= \int_0^{\infty} \left[\int_0^{\infty} f(t) dt \right] du \\
 &= \int_0^{\infty} S(u) du
 \end{aligned}$$

Or by using
the fact that



$$dS(u) = d[1 - F(u)] = -f(u) du$$

and integrating by parts and using
the fact that

$$S(0) = 1, \quad S(\infty) = 0$$

$$\underbrace{-t S(u)}_{=0} \Big|_0^{\infty} + \int_0^{\infty} S(t) dt$$

$$h(t) = \lim_{\sigma \rightarrow 0} \frac{P(t \leq T < t + \sigma | T \geq t)}{\sigma}$$

$$= \lim_{\sigma \rightarrow 0} \frac{P(t \leq T < t + \sigma)}{P(T \geq t) \cdot \sigma}$$

$$= \lim_{\sigma \rightarrow 0} \frac{S(t) - S(t + \sigma)}{\sigma} \cdot \frac{1}{S(t)}$$

$$= f(t) \cdot \frac{1}{S(t)} = \frac{f(t)}{S(t)} = -\frac{d \ln S(t)}{dt}$$

$$H(t) = \int_0^t h(u) du = -\int_0^t \frac{1}{S(u)} dS(u)$$

$$= -\ln[S(t)] + \ln[S(0)]$$

$$= -\ln[S(t)] + \ln(1) = -\ln S(t)$$

$$\Rightarrow S(t) = e^{-H(t)}$$

$$h(x) = \frac{f(x)}{S(x)}$$

Memoryless property:

$$P(X > s+t | X > s) = P(X > t)$$

$$= \frac{P(X > s+t \wedge X > t)}{P(X > s)}$$

$$= \frac{P(X > s+t)}{P(X > s)} = \frac{e^{-\lambda(s+t)}}{e^{-\lambda s}} = e^{-\lambda t}$$

The past does not influence the future, every time is like the beginning of a new random period, which has the same distribution regardless how much time has already passed

$$X \sim \text{Exp}(\lambda)$$

We know that $X > s$, $P(X > s+t) = ?$

This type of problems occurs in queueing systems where we are interested in time between events.

$$f(x) = \frac{1}{\sigma} e^{-x/\sigma}$$

$$x \geq 0, \sigma > 0$$

$$E X = \sigma$$

$$F(x) = \begin{cases} 0 & x < 0 \\ 1 - e^{-x/\sigma} & x \geq 0 \end{cases}$$

$X \sim \text{exp}$ with a mean of 40

$$f(x) = \frac{1}{40} e^{-x/40}$$

$$\begin{aligned} P(X < 36) &= \int_0^{36} \frac{1}{40} e^{-x/40} dx \\ &= 1 - e^{-36/40} \\ &= \text{pexp}(36, 1/40) = 0.593 \end{aligned}$$

median: $F(m) = 0.5$

$$1 - e^{-m/\sigma} = 0.5$$

$$q\text{exp}(0.5, 1/40)$$

N.B. 1 in R: $f(x) = \lambda e^{-\lambda x}$

plot the p.d.f.

Ex: the life of a certain type of electronic component has an exponential distr. with a mean life of 500 hours. If X denote the life time of this component (or the time to failure of this component) then

$$P(X > x) = \int_x^{\infty} \frac{1}{500} e^{-t/500} dt$$

$$= e^{-x/500}$$

Suppose that the component has been operating for 300 hours, what is the conditional pr. that it will last for another 600 hours?

$$P(X > 900 | X > 600) = \frac{P(X > 900)}{P(X > 600)}$$

$$= \frac{e^{-900/500}}{e^{-600/500}} = e^{-6/5} = P(X > 600)$$

for each component an old component is as good as the new one

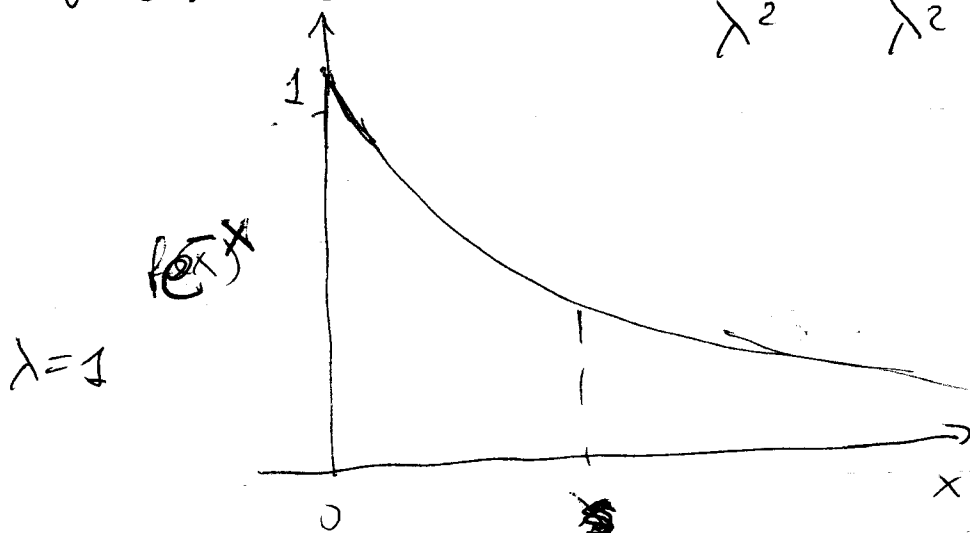
$$EX = \int_0^{\infty} x \lambda e^{-\lambda x} dx$$

$$= \lambda \left[-\frac{x e^{-\lambda x}}{\lambda} \right]_0^{\infty} + \frac{1}{\lambda} \int_0^{\infty} e^{-\lambda x} dx$$

$$= \lambda \left[0 + \frac{1}{\lambda} = \frac{e^{-\lambda x}}{\lambda} \right]_0^{\infty} = \lambda \cdot \frac{1}{\lambda^2} = \frac{1}{\lambda}$$

$$EX^2 = \int_0^{\infty} x^2 \lambda e^{-\lambda x} dx = \dots \frac{2}{\lambda^2}$$

$$\text{Var } X = EX^2 - EX = \frac{2}{\lambda^2} - \frac{1}{\lambda^2} = \frac{1}{\lambda^2}$$



Memoryless: The graph after s is exactly an exact copy of the original. \Rightarrow the distribution of X conditioned on $\{X > s\}$ is again exponential!